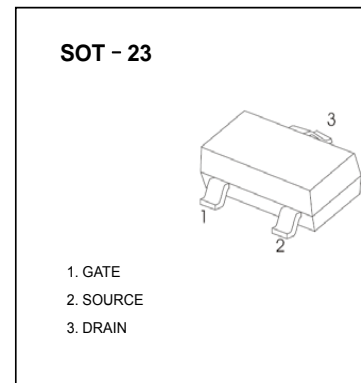


MOSFET PRODUCT SUMMARY

V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
30 V	85 mΩ @ 10 V	2.5 A
	105 mΩ @ 4.5 V	

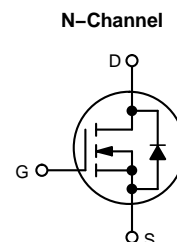


Features

- Leading Planar Technology for Low Gate Charge / Fast Switching
- 4.5 V Rated for Low Voltage Gate Drive
- These Devices are Pb-Free and are RoHS Compliant

Applications

- DC-DC Conversion
- Load/Power Switch for Portables
- Load/Power Switch for Computing



MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V _{DSS}	30	V	
Gate-to-Source Voltage		V _{GS}	±20	V	
Continuous Drain Current (Note 1)	Steady State	T _A = 25°C	I _D	2.0	A
		T _A = 85°C		1.5	
	t ≤ 10 s	T _A = 25°C		2.5	
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	0.73	W
Continuous Drain Current (Note 2)	Steady State	T _A = 25°C	I _D	1.5	A
		T _A = 85°C		1.1	
Power Dissipation (Note 2)		T _A = 25°C	P _D	0.42	W
Pulsed Drain Current	t _p = 10 μs	I _{DM}	10	A	
Operating Junction and Storage Temperature		T _J , T _{stg}	-55 to 150	°C	
Source Current (Body Diode)		I _S	2.0	A	
Peak Source Current (Diode Forward)	t _p = 10 μs	I _{SM}	4.0	A	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T _L	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	R _{θJA}	170	°C/W
Junction-to-Ambient - t < 10 s (Note 1)	R _{θJA}	100	
Junction-to-Ambient - Steady State (Note 2)	R _{θJA}	300	

1. Surface-mounted on FR4 board using 1 in sq pad size.
2. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA	30	36		V
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V			1.0	μA
		V _{GS} = 0 V, V _{DS} = 24 V, T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V			±100	nA

ON CHARACTERISTICS (Note 3)

Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 250 μA	1.0	1.75	3.0	V
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 2.5 A		85	110	mΩ
		V _{GS} = 4.5 V, I _D = 2.0 A		105	140	
Forward Transconductance	g _{FS}	V _{DS} = 4.5 V, I _D = 2.5 A		5.3		S

CHARGES AND CAPACITANCES

Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V		135		pF
Output Capacitance	C _{oss}			52		
Reverse Transfer Capacitance	C _{rss}			15		
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 24 V		130	250	pF
Output Capacitance	C _{oss}			42	75	
Reverse Transfer Capacitance	C _{rss}			13	25	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 2.5 A		3.6	7.0	nC
Threshold Gate Charge	Q _{G(TH)}			0.3		
Gate-to-Source Charge	Q _{GS}			0.6		
Gate-to-Drain Charge	Q _{GD}			0.7		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 24 V, I _D = 2.5 A		1.9		nC
Threshold Gate Charge	Q _{G(TH)}			0.3		
Gate-to-Source Charge	Q _{GS}			0.6		
Gate-to-Drain Charge	Q _{GD}			0.9		

SWITCHING CHARACTERISTICS (Note 4)

Turn-On Delay Time	t _{d(on)}	V _{GS} = 10 V, V _{DD} = 15 V, I _D = 1 A, R _G = 6 Ω		5.8	12	ns
Rise Time	t _r			5.8	10	
Turn-Off Delay Time	t _{d(off)}			14	25	
Fall Time	t _f			1.6	5.0	
Turn-On Delay Time	t _{d(on)}	V _{GS} = 10 V, V _{DD} = 24 V, I _D = 2.5 A, R _G = 2.5 Ω		4.8		ns
Rise Time	t _r			6.7		
Turn-Off Delay Time	t _{d(off)}			13.6		
Fall Time	t _f			1.8		

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 2.0 A		0.85	1.2	V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, I _S = 2.0 A, dI _S /dt = 100 A/μs		9.2		ns
Reverse Recovery Charge	Q _{RR}			4.0		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

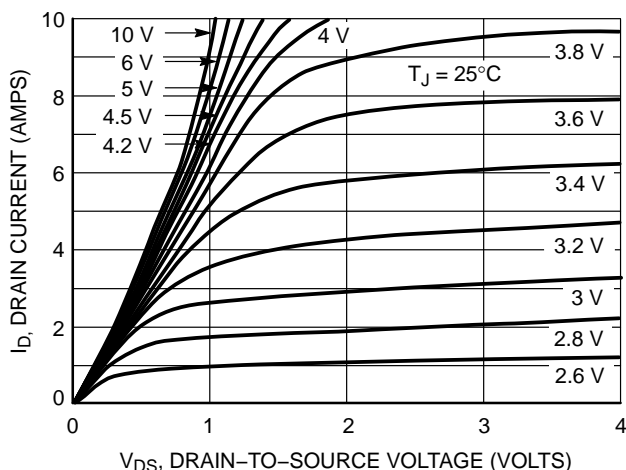


Figure 1. On-Region Characteristics

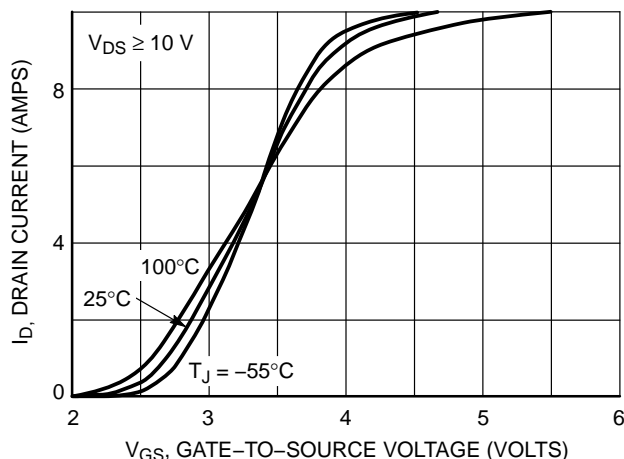


Figure 2. Transfer Characteristics

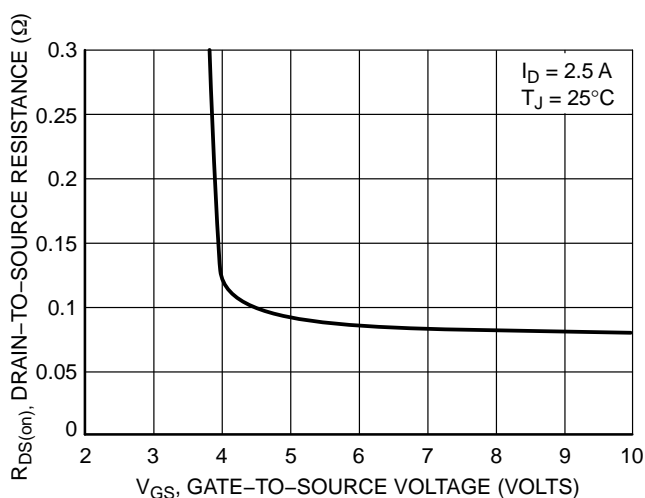


Figure 3. On-Resistance vs. Gate-to-Source Voltage

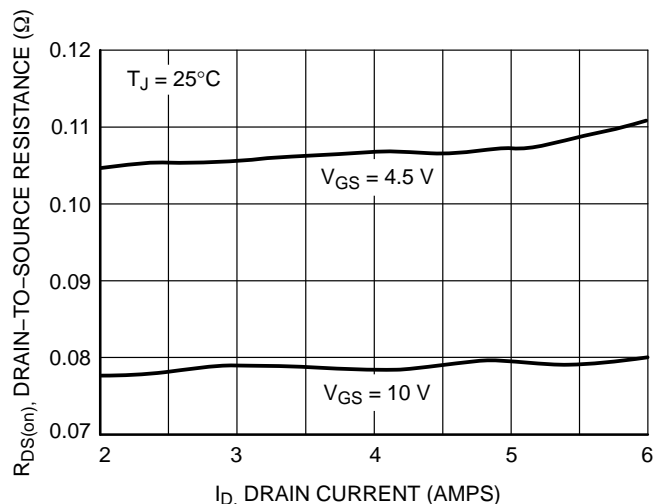


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

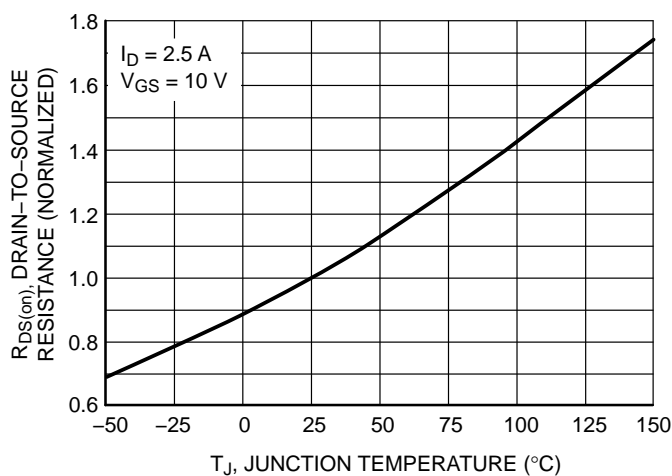


Figure 5. On-Resistance Variation with Temperature

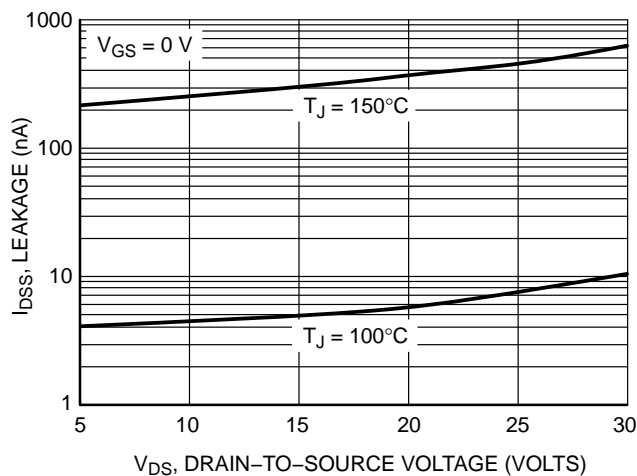


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES

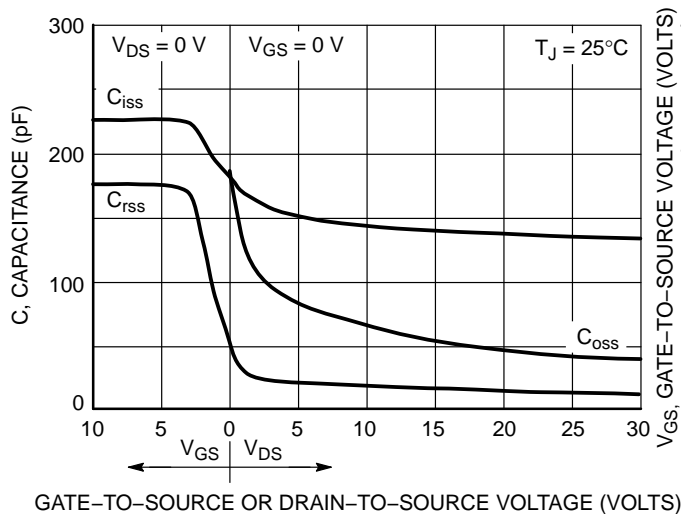


Figure 7. Capacitance Variation

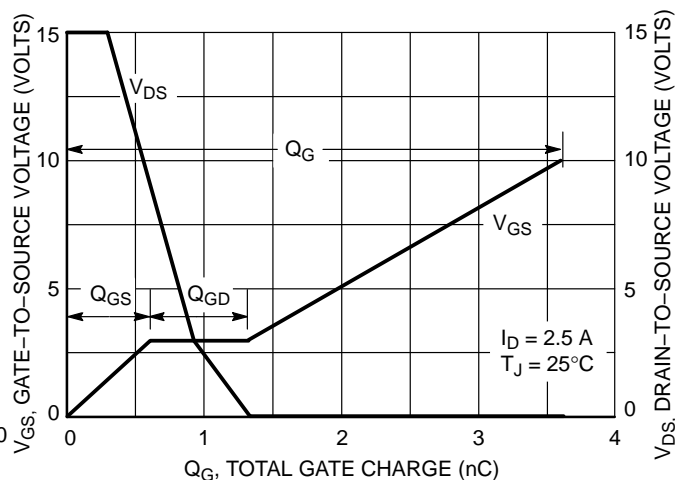


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

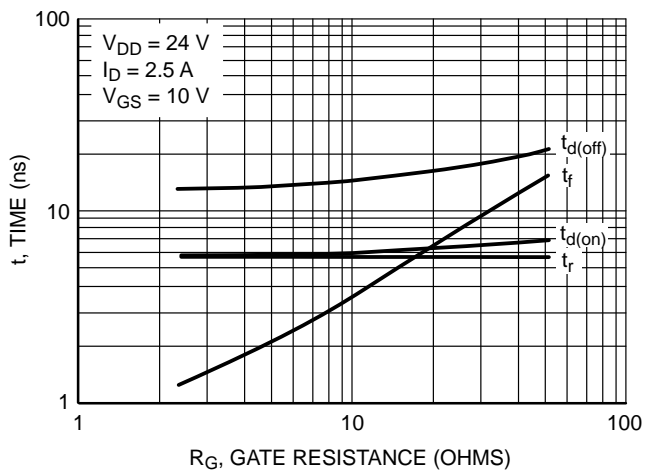


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

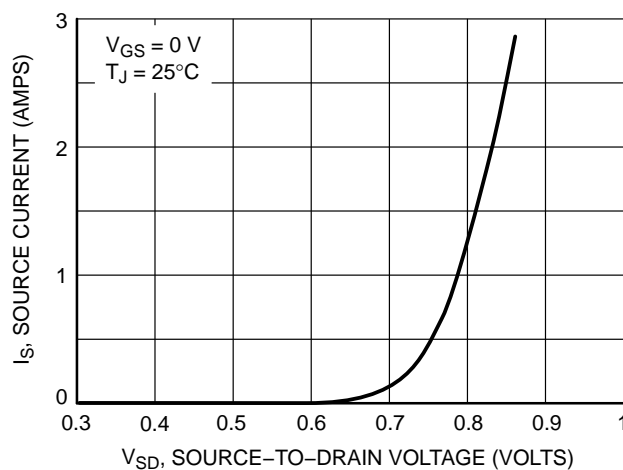
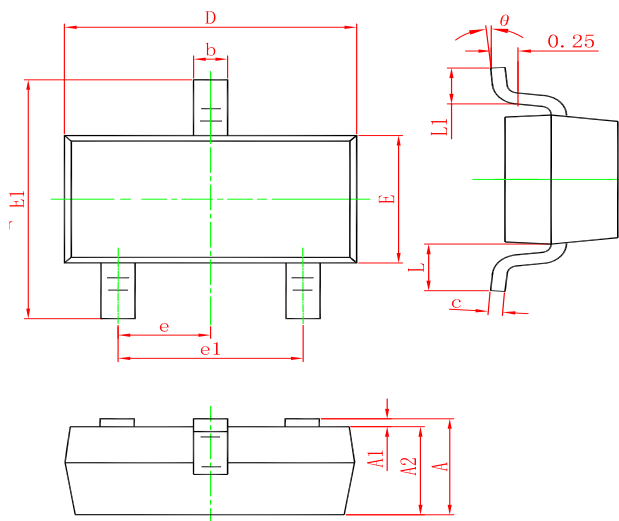


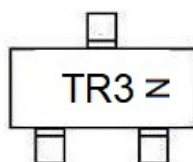
Figure 10. Diode Forward Voltage vs. Current

SOT-23 PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.550 REF.		0.022 REF.	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Marking



Ordering information

Order code	Package	Baseqty	Deliverymode
UMW NTR4503NT1G	SOT-23	3000	Tape and reel